



Sheet: 1 of: 1

FORM: PTO-1449 (REV: 7-80) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE				Atty Docket No: 98-1068.02	Serial No: 09/652,999
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (37 CFR 1.98(b))				Applicant: D. Mark Durcan et al.	
				Filing Date: 8/31/00	Group:

#### U.S. PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Name	Class	Subclass	
DLN	AA 6,048,763	04/11/00	Doan et al.	438	239	
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					

#### FOREIGN PATENT DOCUMENTS

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes	Translation No
	AL					<input type="checkbox"/>	<input type="checkbox"/>
	AM					<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>
	AQ					<input type="checkbox"/>	<input type="checkbox"/>

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#### OTHER ART (including author, title, date, pertinent pages, etc.)

DLN	AR		U. S. Patent Application, Serial No. 09/389,661, METHOD OF FORMING A CONTACT STRUCTURE AND A CONTAINER CAPACITOR STRUCTURE, by D. Mark Durcan, Trung T. Doan, Roger R. Lee, and Fernando Gonzalez, filed September 2, 1999, Micron Technology, Inc. docket No. 99-0052.
	AS		
	AT		

Examiner:

Delish Nguyen

Date Considered:

5/18/01

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.

FORM: PTO-1449 (REV: 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE <b>SUPPLEMENTAL</b> <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (37 CFR 1.98(b))	Atty Docket No: <b>98-1068.02</b>	Serial No: <b>09/652,999</b>
O I P E (use several sheets if necessary)		Applicant: <b>D. Mark Durcan et al.</b>	
		Filing Date: <b>8/31/00</b>	Group: <b>2811</b>

FEB 23 2001

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass
DLN	AA 5,930,641	07/27/99	Pan	438	398
	AB 5,925,921	07/20/99	Susak	257	532
	AC 5,866,453	02/02/99	Prall et al.	438	253
	AD 5,793,076	08/11/98	Fazan et al.	257	298
	AE 5,786,250	07/28/98	Wu et al.	438	254
	AF 5,498,562	03/12/96	Dennison et al.	437	052
↓	AG 5,488,011	01/30/96	Figura et al.	437	060
	AH 4,937,096	06/26/90	Arakawa et al.	427	080
AI					
AJ					
AK					

**FOREIGN PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation Yes	Translation No
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AO						<input type="checkbox"/>	<input type="checkbox"/>
AP						<input type="checkbox"/>	<input type="checkbox"/>
AQ						<input type="checkbox"/>	<input type="checkbox"/>

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**OTHER ART** (including author, title, date, pertinent pages, etc.)

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Examiner:

*Debra Ruyer*

Date Considered:

5/22/01

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.

*SEARCHED*  
*INDEXED*  
*MAILED 5/22/01*  
*REVIEWED*

FORM: PTO-1449 (REV: 7-80) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE <b>SECOND SUPPLEMENTAL</b> <b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b> (37 CFR 1.98(b)) <i>(use several sheets if necessary)</i>					Atty Docket No: 98-1068.02	Serial No: 09/652,999
					Applicant: <b>D. Mark Durcan et al.</b>	
					Filing Date: 8/31/00	Group: 2811

**U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass
DLN	AA 6,063,656	05/16/00	Clampitt	438	239
DLN	AB 5,851,875	12/22/98	Ping	438	253
DLN	AB 5,702,968	12/30/97	Chen	437	052
DLN	AC 5,362,666	11/08/94	Dennison	437	052
DLN	AD 5,340,763	08/23/94	Dennison	437	052
DLN	AE 5,338,700	08/16/94	Dennison et al.	437	060
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**FOREIGN PATENT DOCUMENTS**

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	AQ					<input type="checkbox"/>	<input type="checkbox"/>

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**OTHER ART** (including author, title, date, pertinent pages, etc.)

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Examiner:	<i>Deletha Nguyen</i>	Date Considered:	<i>5/21/01</i>
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication with applicant.